Obsolete - Part Discontinued





PI3EQX25904

25Gbps 4-Channel ReDriver with Linear Equalization

Features

- → 2.5 to 25Gbps Serial Link with Linear Equalizer
- → Supports SAS3/ SAS4/ IB FDR/ PCIe4/ UPI Protocols
- → Supporting Four Differential Channels
- → Handles up to 20dB Channel Loss (~30" FR4 Trace or 7m of High-Speed Low-Loss Cable)
- → Independent Channel Configuration of Receiver Equalization, Output Swing, and Flat Gain
- → Rate and Coding Agnostic
- → Transparent to Link Training, OOB
- → Pin Strap and I²C Selectable Device Programming
- → 3-bit Selectable Address bit for I²C
- → Supply Voltage: 3.3V±0.3V
- → Industrial Temperature Range: -40°C to 85°C
- → Pin Strap Value Latched into I²C Register
- → Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- → Halogen and Antimony Free. "Green" Device (Note 3)
- → Packaging (Pb-free & Green):
 - 42-Contact TQFN (9mm × 3.5mm)

Description

Diodes' PI3EQX25904 is a multi-data rate, four differential channels ReDriver $^{\infty}$. The device provides programmable linear equalization, output swing, and flat gain by either pin strapping option or I 2 C control to optimize performance over a variety of physical mediums by reducing intersymbol interference.

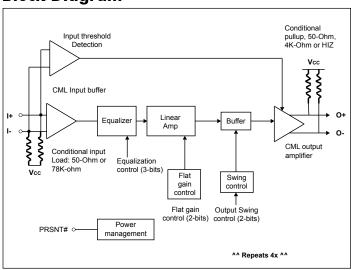
PI3EQX25904 supports four 100Ω differential CML data I/Os and extends the signals across other distant data pathways on the user's platform.

The integrated equalization circuitry provides flexibility with signal integrity of the signal before the ReDriver, whereas the integrated linear amplifier/buffer circuitry provides flexibility with signal integrity of the signal after the ReDriver.

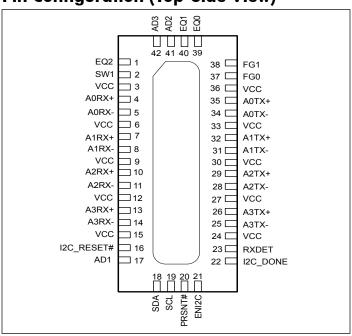
Applications

- → Networking
- **→** Enterprise
- → Server
- **→** Storage

Block Diagram



Pin Configuration (Top-Side View)



Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.





Pin Des	Pin Description							
Pin#	Pin Name	Type	Description					
Data Signa	ls							
4	A0RX+	I	CMI impute for Channel A0 with internal 500 multim and 70VO to White Dy otherwise					
5	A0RX-	I	CML inputs for Channel A0 with internal 50 Ω pullup and ~78K Ω to Vbias Rx otherwise.					
35	A0TX+	О	CML outputs for Channel A0 with internal 50 Ω pullup, 4K Ω to Vbias Tx, or high impedance.					
34	A0TX-	О	CIVIL outputs for Channel Ao with Internal 3032 pullup, 4K32 to Volas 1x, of high impedance.					
7	A1RX+	I	CML inputs for Channel A1 with internal 50 Ω pullup and ~78K Ω to Vbias Rx otherwise.					
8	A1RX-	I	Civil inputs for Chainfel At with internal 3022 puntup and 470K22 to 7 bias Kx otherwise.					
32	A1TX+	О	CML outputs for Channel A1 with internal 50 Ω pullup, 4K Ω to Vbias Tx, or high impedance.					
31	A1TX-	О	Civil outputs for Chamier At with internal 3012 puntup, 4K12 to voias 1x, or high impedance.					
10	A2RX+	I	CML inputs for Channel A2 with internal 50 Ω pullup and ~78K Ω to Vbias Rx otherwise.					
11	A2RX-	I	Civil inputs for Chaimer 1/2 with internal 3032 puntup and 1/3 0K32 to 1/3 KX other wise.					
29	A2TX+	О	CML outputs for Channel A2 with internal 50 Ω pullup, 4K Ω to Vbias Tx, or high impedance.					
28	A2TX-	О	Civil outputs for Chamier 712 with internal 3012 puntup, 4132 to voias 1x, or high impedance.					
13	A3RX+	I	CML inputs for Channel A3 with internal 50 Ω pullup and ~78K Ω to Vbias Rx otherwise.					
14	A3RX-	I	CIVIL inputs for Chaimer A3 with internal 3032 pullup and ~70K32 to v bias Kx otherwise.					
26	A3TX+	О	CML outputs for Channel A3 with internal 50 Ω pullup, 4K Ω to Vbias Tx, or high impedance.					
25	A3TX- O		Civil outputs for Chainlet A3 with internal 3032 pullup, 4K32 to voias 1x, or high impedance.					
Control Sig	gnals							
19	SCL	I/O	I ² C SCL Clock. In Master mode (ENI2C floating), SCL is an output. Otherwise, it is an input.					
18	SDA	I/O	I ² C SDA data input/output.					
42, 41, 17	AD[3:1]	I	I^2C programmable address bits with internal $300k\Omega$ pullup.					
20	PRSNT#	I	This pin is active in both PIN mode (ENI2C=LOW) and I^2C mode (ENI2C=HIGH). Cable present detect input. This pin has internal 300K Ω pullup. When HIGH, a cable is not present, and the device is put in lower power mode. When LOW, the device is enabled and in normal operation.					
21	ENI2C	I	When LOW, each channel is programmed by the external pin voltage. When HIGH, each channel is programmed by the data stored in the $\rm I^2C$ bus. When floating, Master mode (Read External EEPROM). Input with 150K Ω pullup and down.					
1, 40, 39	EQ[2:0]	I	Inputs with internal 300k Ω pullup. This pin set the amount of Equalizer Boost in all channels when ENI2C is LOW.					
2	SW1	I	Inputs with internal 300k Ω pullup. This pin sets the output Voltage Level in all channels when ENI2C is LOW.					
38, 37	FG[1:0]	I	Inputs with internal $300 \text{K}\Omega$ pullup resistor. Sets the output flat gain level on all channels when ENI2C is low.					
16	I2C_RESET#	I	Inputs with internal 300K Ω pullup resistor. Reset pin for I ² C. When set low will reset the registers to default state.					





Pin Description Cont.

2 333	in Description donn						
Pin #	Pin Name	Type	Description				
22	I2C_DONE	О	Valid register load status output, use for daisy chain master. LOW = External EEPROM load failed HIGH = External EEPROM load passed				
23	RXDET	I	This pin is active in both PIN mode(ENI2C=LOW) and I2C mode (ENI2C=HIGH). The RXDET pin controls the receiver detect function. Tie High = Enable receiver detect to support PCIe 3.0/4.0 and UPI interface Tie Low = Disable receiver detect to support SATA3/SAS3/SAS4 interface, input is 50Ω to VDD RXDET pin has 300K-ohm internal pull-up				
Power Pins							
3, 6, 9, 12, 15, 24, 27, 30, 33, 36	V_{CC}	PWR	3.3V Supply Voltage				
EP	GND	PWR	Exposed pad. Supply Ground.				

Note: 1. Be sure to use good conductive adhesive to properly attach package Ground Pad to PCB pad. This is both for thermal nd electrical conduction.





Description of Operation

Power Enable Function:

One pin control or I2C control. When PRSNT# is set to HIGH, the IC goes into power down mode, and both input and output termination set to 78K and high impedance respectively. Individual Channel Enabling is done through the I2C register programming.

Equalization Setting:

EQ[2:0] are the selection pins for the equalization selection.

Table 1. Equalization Setting

	Equalizer Setting (dB)								
EQ2	EQ1	EQ0	@1.25GHz	@2.5GHz	@4GHz	@8GHz	@10GHz	@12.5GHz	
0	0	0	0.2	0.7	1.7	4.4	5.8	7.3	
0	0	1	0.6	2.0	4.0	8.3	9.9	11.5	
0	1	0	1.1	3.3	6.0	11.2	13.0	14.9	
0	1	1	1.6	4.5	7.7	13.5	15.6	17.9	
1	0	0	2.2	5.6	9.0	14.7	16.7	18.8	
1	0	1	4.3	7.3	10.4	15.7	17.5	19.3	
1	1	0	4.7	8.1	11.2	16.5	18.3	20.0	
1	1	1	5.2	8.8	12.0	17.4	19.2	20.8	

Flat Gain Setting:

FG[1:0] are the selection bits for the DC gain.

Table 2. Flat Gain Setting

Flat Gain Setting						
FG1 FG0 dB						
0	0	-4				
0	1	-2				
1	0	0				
1	1	2				

Swing Setting:

SW[1:0] are the selection bits for the output swing value.

Table 3. Swing Setting

Output Swing Setting						
SW1 SW0 mVp-p						
0	0	800				
0	1	1000				
1	0	1000				
1	1	1200				

Note: SW0 is from I2C, SW1 is from pin or I2C.





I²C Programming

Address Assignment								
A6	A5	A4	A3	A2	A1	A0	R/W	
1	1	1	AD3	AD2	AD1	0	1=R, 0=W	

	1 1	I MD3	MDZ	ADI	· ·	1-10, 0-11
Reserved						
Reserved						
Type	Powerup Condition	_		Control Afl	fected (Comment
R/W	0	_		A3 Powerdov	vn	
R/W	0	_		A2 Powerdov	vn	
R/W	0	_		A1 Powerdov	vn	
R/W	0	_		A0 Powerdov	vn	= Powerdown
R/W	0	_		_	1	= Powerdown
R/W	0	_		_		
R/W	0	_		_		
R/W	0	_		_		
•						
Type	Powerup Condition			Control Af	fected (Comment
R/W	0			_		
R/W	EQ2			EQ2		·1:
R/W	EQ1			EQ1	E	lqualizer
R/W	EQ0	Cl 1	10 Comformati	EQ0		
R/W	FG1	Cnannel	AU Configuration	FG1	T	lat Cain
R/W	FG0			FG0	F	lat Gain
R/W	SW1			SW1		
R/W	1			SW0	S	wing
	Type	Reserved	Type	Type	Reserved	Type





I²C Programming Cont.

BYTE 4	4					
Bit	Type	Powerup Condition		Control Affected	Comment	
7	R/W	0		_		
6	R/W	EQ2		EQ2	. I.	
5	R/W	EQ1		EQ1	Equalizer	
4	R/W	EQ0		EQ0		
3	R/W	FG1	Channel A1 Configuration	FG1	F1 + C :	
2	R/W	FG0		FG0	Flat Gain	
1	R/W	SW1		SW1	0	
0	R/W	1		SW0	Swing	
BYTE :	5					
Bit	Type	Powerup Condition		Control Affected	Comment	
7	R/W	0		_		
6	R/W	EQ2		EQ2	Equalizer	
5	R/W	EQ1		EQ1		
4	R/W	EQ0		EQ0		
3	R/W	FG1	Channel A2 Configuration	FG1	Flat Gain	
2	R/W	FG0		FG0		
1	R/W	SW1		SW1	Swing	
0	R/W	1		SW0		
BYTE	6					
Bit	Type	Powerup Condition		Control Affected	Comment	
7	R/W	0		_		
6	R/W	EQ2		EQ2	. I.	
5	R/W	EQ1		EQ1	Equalizer	
4	R/W	EQ0		EQ0		
2	R/W	FG1	Channel A3 Configuration	FG1	F1 . C .	
3		FG0		FG0	Flat Gain	
2	R/W	1 00			_	
	R/W R/W	SW1		SW1	Swing	

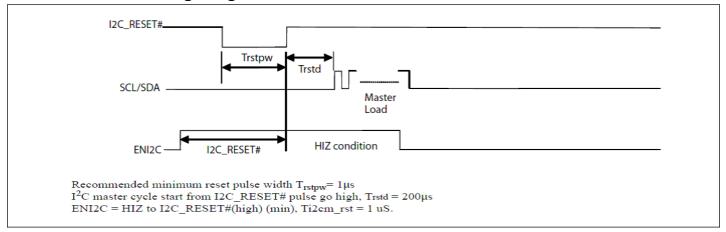
6

June 2019





Reset and I2CM Timing Diagram



I2C Operation

The integrated I2C interface operates as a master or slave device depending on the pin ENI2C being HIZ or HIGH respectively. Standard mode (100Kbps) is supported with 7-bit addressing. The data byte format is 8-bit bytes and supports the format of indexing to be compatible with other bus devices. In the Slave mode (ENI2C = HIGH), the device supports Read/Write. The bytes must be accessed in sequential order from the lowest to the highest byte with the ability to stop after any complete byte has been transferred.

Address bits A3 to A1 are programmable to support multiple chips environment.

In the master mode (ENI2C = HIZ), PI3EQX25904 supports up to eight masters connected in daisy chain through connecting I2C_DONE pin to I2C_RESET# pin of the next part.

Master EEPROM data starting address for device address:

I2C Address: AD3, AD2, AD1	Data Starting Location
000	00H
001	10H
010	20H
011	30H
100	40H
101	50H
110	60H
111	70H





Transferring Data

Every byte put on the SDA line must be 8-bits long. Each byte must be followed by an acknowledge bit. Data is transferred with the most significant bit (MSB) first (see the I2C Data Transfer diagram). The PI3EQX25904 never holds the clock line SCL LOW to force the master into a wait state.

Acknowledge

Data transfer with acknowledge is required from the master. When the master releases the SDA line (HIGH) during the acknowledge clock pulse, the PI3EQX25904 pulls down the SDA line during the acknowledge clock pulse, so it remains stable LOW during the HIGH period of this clock pulse as indicated in the I2C Data Transfer diagram. The PI3EQX25904 generates an acknowledge after each byte is received.

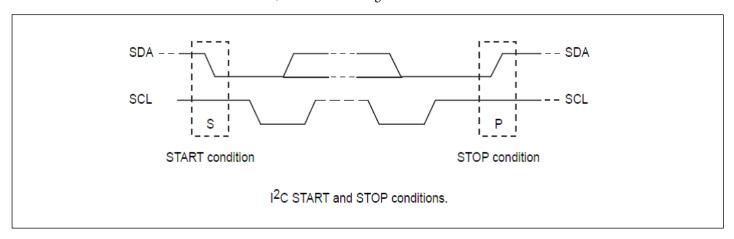
Data Transfer

A data transfer cycle begins with the master issuing a start bit. After recognizing a start bit, the PI3EQX25904 watches the next byte of information for a match with its address setting. When a match is found it responds with a read or write of data on the following clocks. Each byte must be followed by an acknowledge bit, except for the last byte of a read cycle, which ends with a stop bit. For a write cycle, the first data byte following the address byte is an index byte that is used by the PI3EQX25904. Data is transferred with the most significant bit (MSB) first.

12C Data Transfer

Start & Stop Conditions

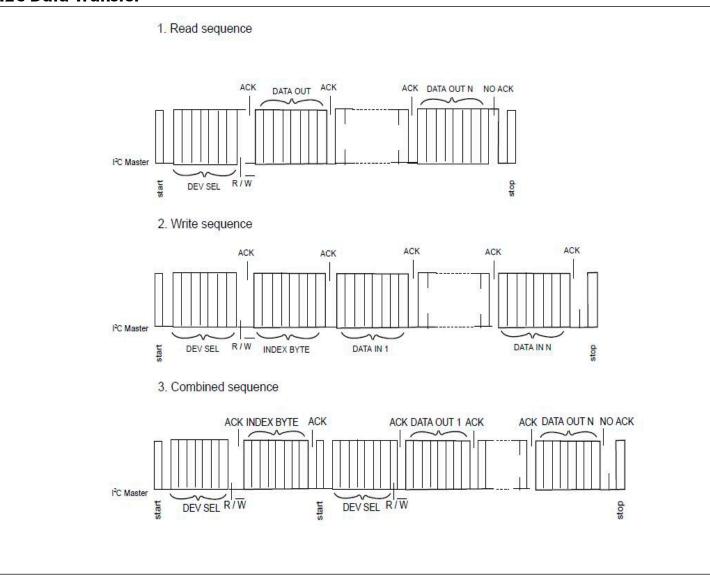
A HIGH-to-LOW transition on the SDA line while SCL is HIGH indicates a START condition. A LOW-to-HIGH transition on the SDA line while SCL is HIGH defines a STOP condition, as shown in the figure below.







I2C Data Transfer







Maximum Ratings

(Above which useful life may be impaired. For user guidelines, not tested.)

Storage Temperature65°C to +150°C
Supply Voltage to Ground Potential0.5V to +3.8V
DC SIG Voltage
Output Current–25mA to +25mA
Power Dissipation Continuous
Max Junction Temperature
ESD, HBM2kV to +2kV

Note:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Electrical Characteristics:

LVCMOS I/O DC Specifications ($V_{CC} = 3.3 \pm 0.3V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
V_{IH}	DC Input Logic High	_	0.4V _{CC}		$V_{CC} + 0.3$	V
V_{IL}	DC Input Logic Low	_	-0.3	_	0.1V _{CC}	V
V_{OH}	At IOH = -200μ A	_	V _{CC} - 0.2	_	_	V
V_{OL}	At IOL = $200\mu A$	_	_		0.2	V

SDA and SCL I/O for I2C-Bus ($V_{CC} = 3.3 \pm 0.3 \text{V}$, $T_{A} = -40 ^{\circ}\text{C}$ to $85 ^{\circ}\text{C}$)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
V_{IH}	DC Input Logic High	_	$V_{\rm CC}/2 + 0.7$	_	V _{CC} + 0.3	V
V_{IL}	DC Input Logic Low	_	-0.3	_	V _{CC} /2 - 0.7	V
V_{OL}	DC Output Logic Low	$I_{OL} = 3mA$	_	_	0.4	V
V _{hys}	Hysteresis of Schmitt Trigger Input	_	0.8	_	_	V
t_{of}	Output Fall Time from VIHmin to VILmax with bus cap. 10pF-400pF	_	_	_	250	ns
f_{SCLK}	SCLK Clock Frequency	_	_	_	100	kHz

High Speed I/O AC/DC Specifications ($V_{CC} = 3.3 \pm 0.3V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units	
C_{RX}	RX AC Coupling Capacitance	_	_	220	_	nF	
S ₁₁	Input Return Loss	2.5GHz to 12.5GHz Differential	_	-6	_	dB	
		2.5GHz to 12.5GHz Common Mode	_	-3	_		
S ₂₂	Output Return Loss	2.5GHz to 12.5GHz Differential	_	-6	_	dB	
		2.5GHz to 12.5GHz Common Mode	_	-3	_		
R _{IN}	DC Single-Ended Input Impedance	_	_	50	_	Ω	
	DC Differential Input Impedance	_	_	100	_		





High Speed I/O AC/DC Specifications Cont.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
R _{OUT}	DC Single-Ended Output Impedance	_	_	50	_	Ω
	DC Differential Output Impedance	_	_	100	_	
$Z_{RX ext{-HIZ}}$	DC input CM Input Impedance During Reset Or Power Down	_	_	200	_	kΩ
V _{RX-DIFF-PP}	Differential Input Peak-to-Peak Voltage	Operational	_	_	1.2	Vppd
	Input Source Common-Mode Noise	DC – 200MHz	_	_	150	mVpp
Vcc	Power Supply Voltage	_	3	3.3	3.6	V
P _{max}	Max Supply Power	PRSNT#=0	_	_	1.3	W
I _{max}	Max Supply Current	_	_	_	360	mA
P _{idle}	Supply Power	PRSNT#=1	_	_	3.6	mW
t _{pd}	Latency	From Input to Output	_	0.1	_	ns
G _P	Peaking Gain (Compensation at 12.5GHz, Relative to 100MHz,	EQ<2:0> = 111 EQ<2:0> = 000		20.8 7.3		dB
	100mVp-p Sine Wave Input)	Variation Around Typical	-3	_	+3	dB
$G_{ m F}$	Flat Gain (100MHz, EQ<2:0> = 100, SW<1:0> = 10)	FG<1:0> = 11 FG<1:0> = 10 FG<1:0> = 01 FG<1:0> = 00	_ _ _ _	2 0 -2 -4	_ _ _ _	dB
		Variation Around Typical	-3	_	+3	dB
V1dB_100M	-1dB Compression Point of Output Swing (at 100MHz)	SW<1:0> = 11 SW<1:0> = 10 SW<1:0> = 01 SW<1:0> = 00	- - - -	1200 1000 1000 800	_ _ _ _	mVppd
$ m V_{1dB_8G}$	-1dB Compression Point of Output Swing (at 12.5GHz)	SW<1:0> = 11 SW<1:0> = 10 SW<1:0> = 01 SW<1:0> = 00	_ _ _ _	900 700 700 500	_ _ _ _	mVppd
V _{Coup}	Channel Isolation	100MHz to 12.5GHz, Figure 1 (Note 1)	_	25	_	dB
Vnoise innut		100MHz to 12.5GHz, FG<1:0> = 10, EQ<2:0> = 000, Figure 2	_	1.1	_	mVn.ss
vnoise_input	Input-Referred Noise	100MHz to 12.5GHz, FG<1:0> = 10, EQ<2:0> = 111, Figure 2	_	6.7		mV _{RMS}





High Speed I/O AC/DC Specifications Cont.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
Vnoise_out-		100MHz to 12.5GHz, FG<1:0> = 10, EQ<2:0> = 000, Figure 2	_	0.9	_	
put		100MHz to 12.5GHz, FG<1:0> = 10, EQ<2:0> = 111, Figure 2	_	1.2	_	mV _{RMS}

Note:

AC/DC Specifications - SCL/SDA for I2C Bus

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
Vih	DC Input Logic High	_	VCC/2 + 0.7	_	VCC + 0.3	V
VIL	DC Input Logic Low	_	-0.3	_	Vcc/2 - 0.7	V
Vol	DC Output Logic Low	IOL = 3mA	_	_	0.4	V
Ipullup	Current Through Pull-Up Resistor or Current Source	High Power Specification	3.0	_	3.6	mA
VDD	Nominal Bus Voltage	_	3.0	_	3.6	V
Ileak-bus	Input Leakage per bus Segment	_	-200	_	200	μΑ
Ileak-pin	Input Leakage per Device pin	_	_	-15	_	μΑ
CI	Capacitance for SDA/SCL	_	_	_	10	pF
Freq	Bus Operation Frequency	_	_	_	100k	Hz
TBUF	"Bus Free Time Between Stop and Start Condition"	_	1.3	_	_	μs
THD:STA	Hold time after (Repeated) Start condition. After this period, the first clock is generated.	At Ipull-up, Max	0.6	_	_	μs
TSU:STA	Repeated Start Condition Setup Time	_	0.6	_	_	μs
TSU:STO	Stop Condition Setup Time	_	0.6	_	_	μs
THD:DAT	Data Hold Time	_	0	_	_	ns
TSU:DAT	Data Setup Time	_	100	_	_	ns
Tlow	Clock Low Period	_	1.3	_	_	μs
Thigh	Clock High Period	_	0.6	_	50	μs
tF	Clock/Data Fall Time	_	_		300	ns
tR	Clock/Data Rise Time	_	_	_	300	ns
tpor	"Time in which a device must be operation after power-on reset"	_	_	_	500	ms

Note: 1. Recommended value.

^{1.} Measured using a vector-network analyzer (VNA) with -15dBm power level applied to the adjacent input. The VNA detects the signal at the output of the victim channel. All other inputs and outputs are terminated with 50Ω .

^{2.} Guaranteed by design and characterization.

^{2.} Recommended maximum capacitance load per bus segment is 400pF.

^{3.} Compliant to I2C physical layer specification.

^{4.} Ensured by Design. Parameter not tested in production.





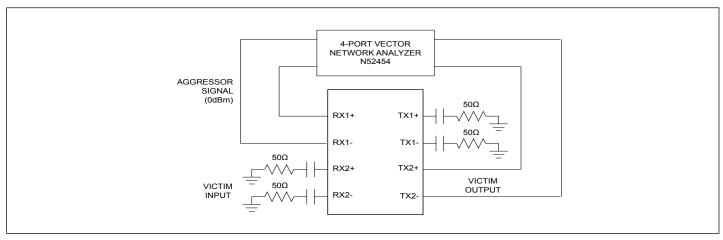


Figure 1. Channel-Isolation Test Configuration

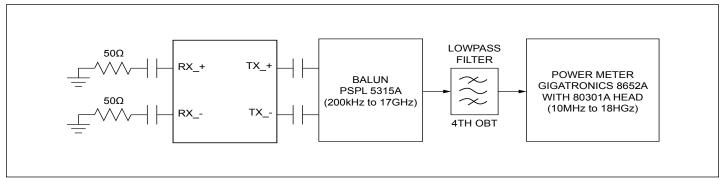


Figure 2. Noise Test Configuration

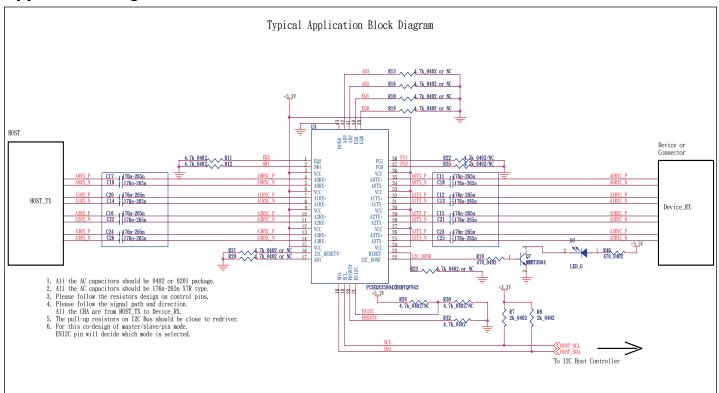




ESD Specification

- 2000V HBM
- 500V CDM

Application Diagram



Part Marking

ZH Package



YY: Year

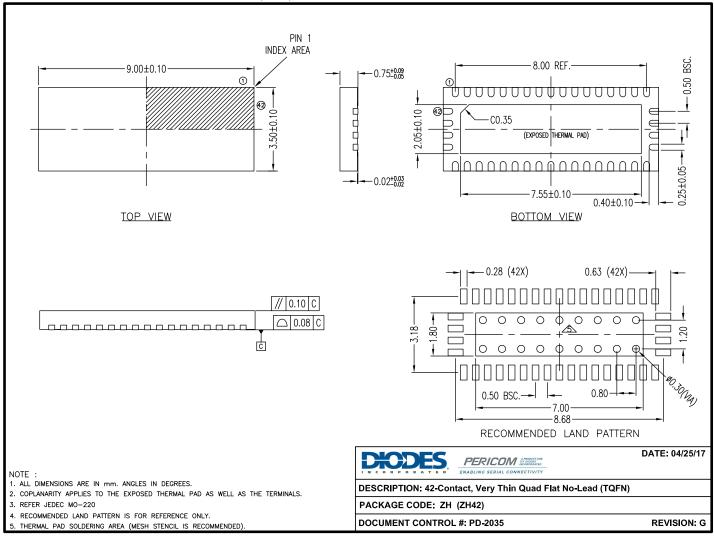
WW: Workweek

1st X: Assembly Code 2nd X: Fab Code





Package Mechanical: 42-TQFN (ZH)



17-0266

For latest package information:

See http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/.

Ordering Information

Ordering Number	Package Code	Package Description
PI3EQX25904ZHEX	ZH	42-Contact, Thin Fine Pitch Quad Flat No-Lead (TQFN)

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. E = Pb-free and Green
- 5. X suffix = Tape/Reel





IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel.

Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
 - 1. are intended to implant into the body, or
- 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2019, Diodes Incorporated www.diodes.com